

**N-Channel Enhancement Mode Power MOSFET**

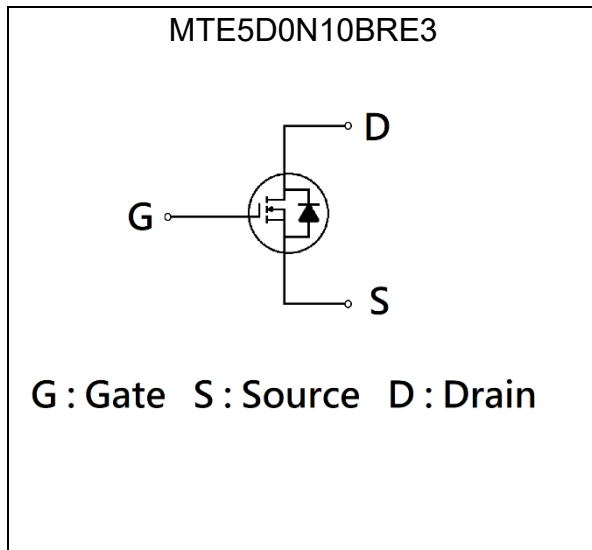
# MTE5D0N10BRE3

**Features**

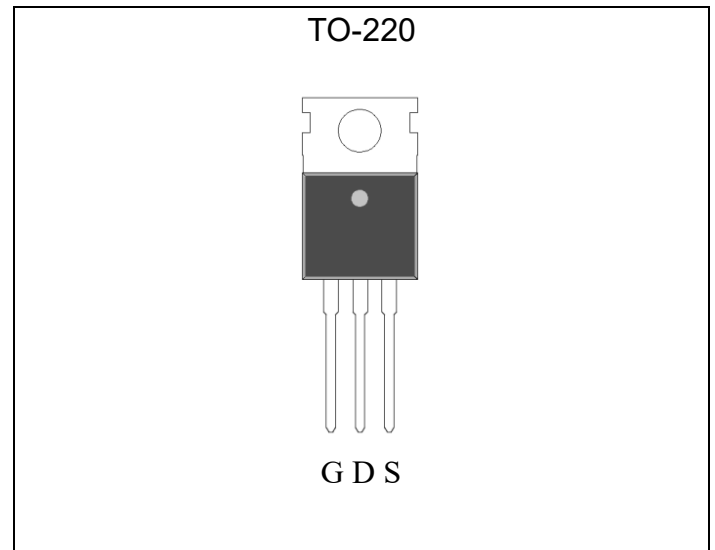
- Low On Resistance
- Simple Drive Requirement
- Low Gate Charge
- Fast Switching Characteristic
- RoHS compliant package

$BV_{DSS}$	100V
$I_D@V_{GS}=10V, T_C=25^{\circ}C$	82A
$I_D@V_{GS}=10V, T_A=25^{\circ}C$	17A
$R_{DS(ON)}@V_{GS}=10V, I_D=20A$	5.9mΩ

**Equivalent Circuit**

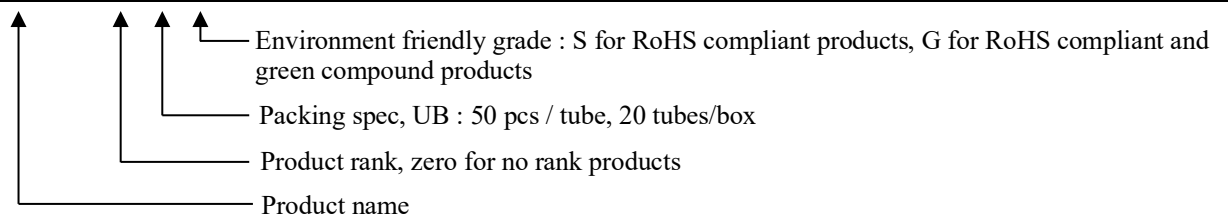


**Outline**



**Ordering Information**

Device	Package	Shipping
MTE5D0N10BRE3-0-UB-X	TO-220 (RoHS compliant)	50 pcs/tube, 20 tubes/box, 4 boxes / carton



**Absolute Maximum Ratings (T<sub>A</sub>=25°C)**

Parameter	Symbol	Limits	Unit	
Drain-Source Voltage	V <sub>DS</sub>	100	V	
Gate-Source Voltage	V <sub>GS</sub>	±20		
Continuous Drain Current @ V <sub>GS</sub> =10V, T <sub>C</sub> =25°C	I <sub>D</sub>	82	A	
Continuous Drain Current @ V <sub>GS</sub> =10V, T <sub>C</sub> =100°C		58		
Continuous Drain Current @ V <sub>GS</sub> =10V, T <sub>A</sub> =25°C		17		
Continuous Drain Current @ V <sub>GS</sub> =10V, T <sub>A</sub> =70°C		14		
Pulsed Drain Current		I <sub>DM</sub>		328
Continuous Body Diode Forward Current @ T <sub>A</sub> =25°C	I <sub>S</sub>	17		
Pulsed Body Diode Forward Current @ T <sub>A</sub> =25°C	I <sub>SM</sub>	68		
Avalanche Current @ L=0.1mH	I <sub>AS</sub>	45		
Avalanche Energy @ L=0.5mH	E <sub>AS</sub>	156	mJ	
Total Power Dissipation	P <sub>D</sub>	T <sub>C</sub> =25°C	115	W
		T <sub>C</sub> =100°C	58	
		T <sub>A</sub> =25°C	5	
		T <sub>A</sub> =70°C	3.5	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55~+175	°C	

**Thermal Data**

Parameter	Symbol	Steady State	Unit
Thermal Resistance, Junction-to-case	R <sub>θJC</sub>	1.3	°C/W
Thermal Resistance, Junction-to-ambient	R <sub>θJA</sub>	30	

Note:

- \*a. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- \*b. The value of R<sub>θJA</sub> is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2 oz. copper, in a still air environment with T<sub>A</sub>=25°C. The power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 175°C. The value in any given application depends on the user's specific board design.
- \*c. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=175°C. Ratings are based on low frequency and low duty cycles to keep initial T<sub>J</sub>=25°C.

**Characteristics (T<sub>A</sub>=25°C, unless otherwise specified)**

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	100	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA
V <sub>GS(th)</sub>	2	-	4		V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA
G <sub>FS</sub>	-	34.4	-	S	V <sub>DS</sub> =10V, I <sub>D</sub> =20A
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V
I <sub>DSS</sub>	-	-	1	μA	V <sub>DS</sub> =80V, V <sub>GS</sub> =0V
R <sub>DS(on)</sub>	-	5.9	8	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =20A
<b>Dynamic</b>					
C <sub>iss</sub>	-	3500	-	pF	V <sub>DS</sub> =50V, V <sub>GS</sub> =0V, f=1MHz
C <sub>oss</sub>	-	450	-		
C <sub>rss</sub>	-	30	-		
R <sub>g</sub>	-	1.4	-	Ω	f=1MHz
Q <sub>g</sub> *1, 2	-	50	-	nC	V <sub>DS</sub> =50V, I <sub>D</sub> =20A, V <sub>GS</sub> =10V
Q <sub>gs</sub> *1, 2	-	20	-		
Q <sub>gd</sub> *1, 2	-	12	-		
t <sub>d(ON)</sub> *1, 2	-	30	-	ns	V <sub>DS</sub> =50V, I <sub>D</sub> =20A, V <sub>GS</sub> =10V, R <sub>GS</sub> =3Ω
t <sub>r</sub> *1, 2	-	18	-		
t <sub>d(OFF)</sub> *1, 2	-	50	-		
t <sub>f</sub> *1, 2	-	12	-		
<b>Source-Drain Diode</b>					
V <sub>SD</sub> *1	-	0.83	1.2	V	I <sub>S</sub> =20A, V <sub>GS</sub> =0V
t <sub>rr</sub>	-	50	-	ns	I <sub>F</sub> =20A, dI <sub>F</sub> /dt=100A/μs
Q <sub>rr</sub>	-	80	-	nC	

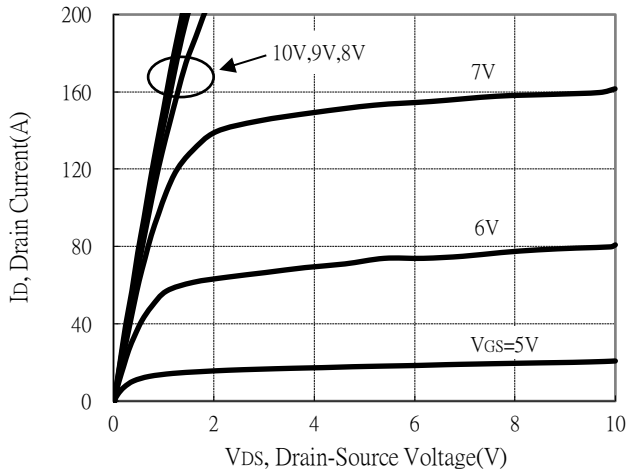
Note:

\*1. Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

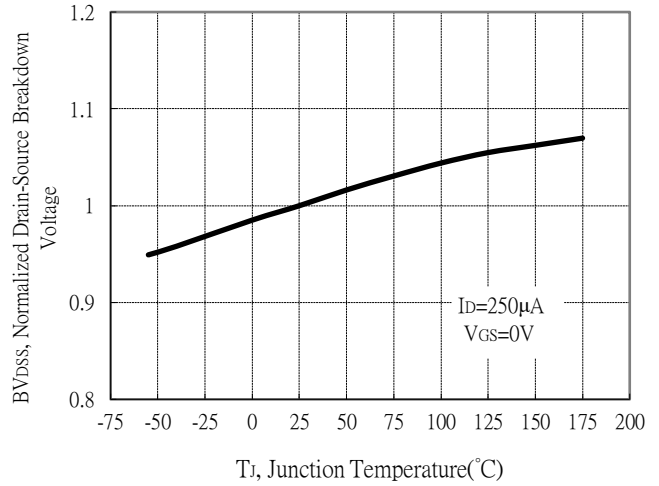
\*2. Independent of operating temperature

## Typical Characteristics

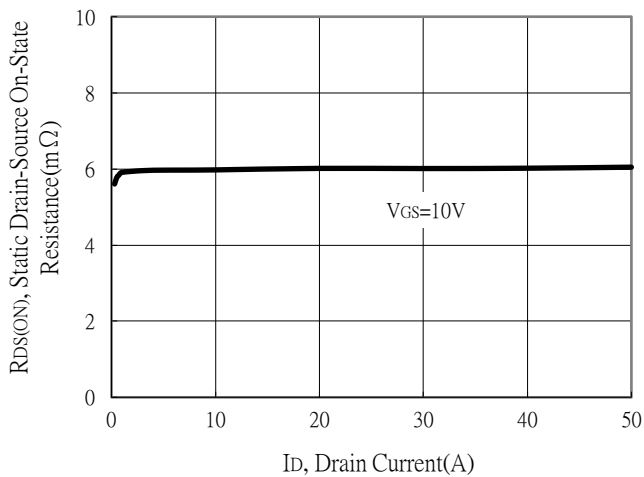
Typical Output Characteristics



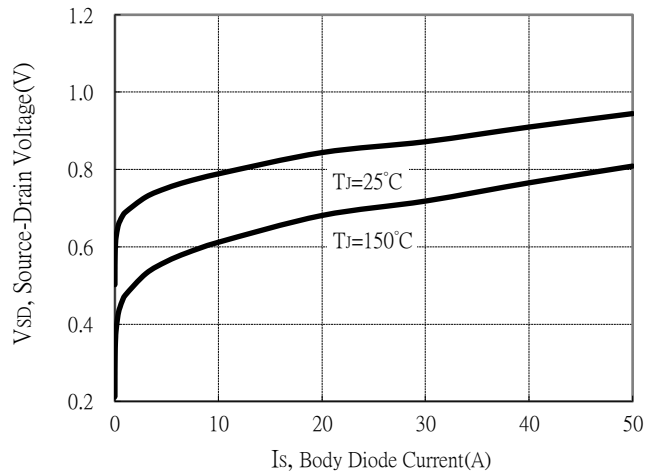
Breakdown Voltage vs Ambient Temperature



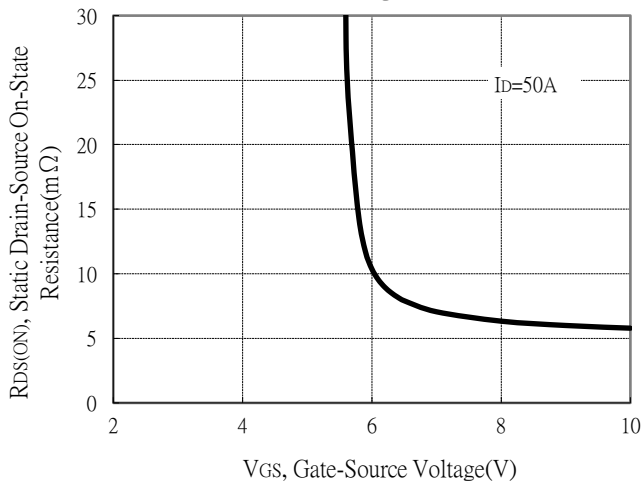
Static Drain-Source On-State resistance vs Drain Current



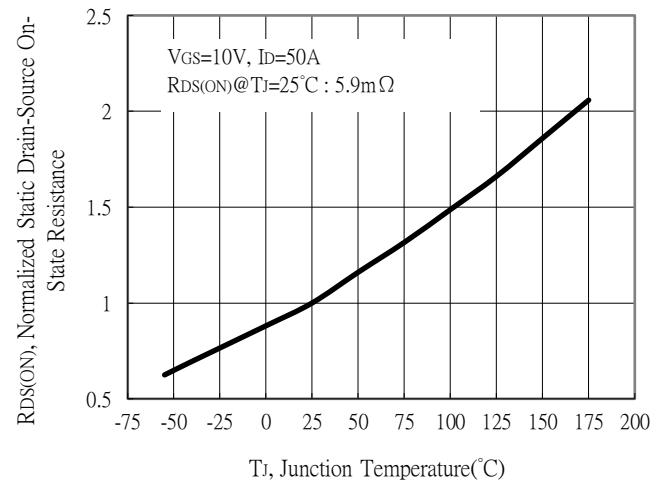
Body Diode Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

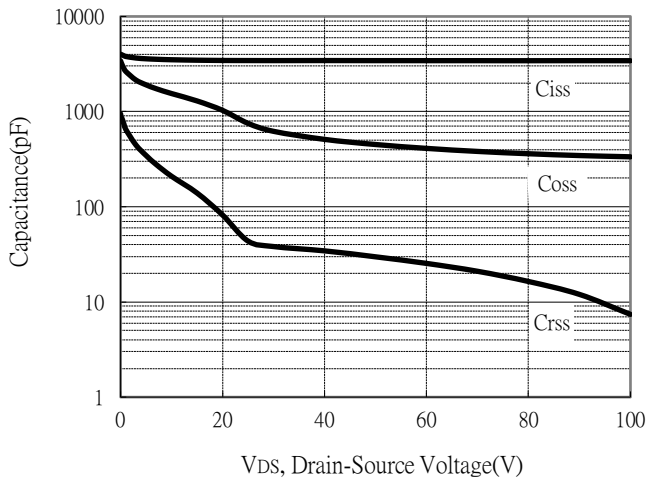


Drain-Source On-State Resistance vs Junction Temperature

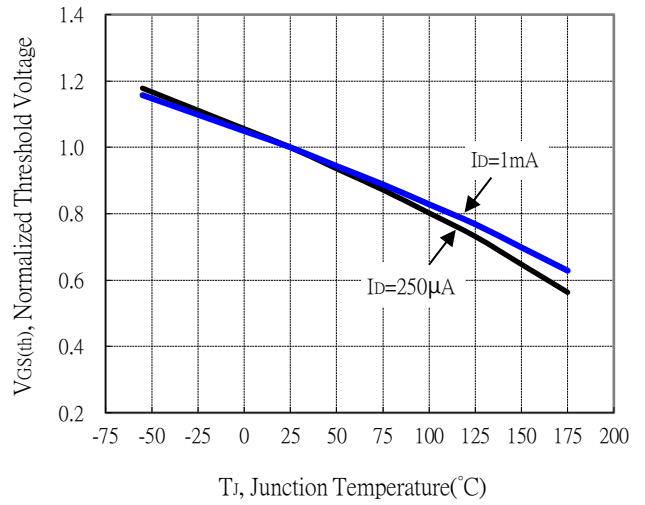




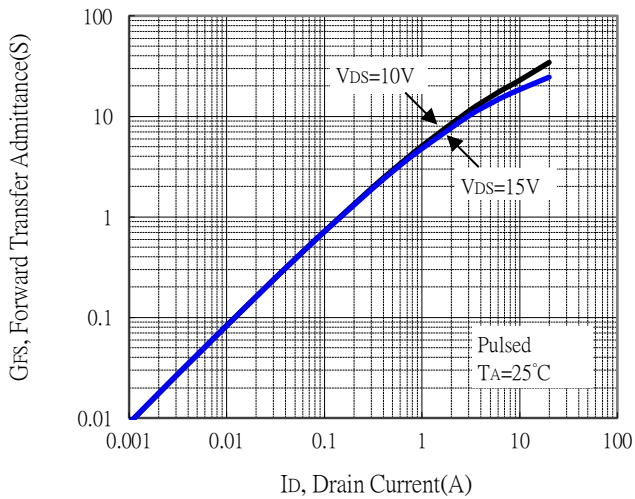
Capacitance vs Drain-to-Source Voltage



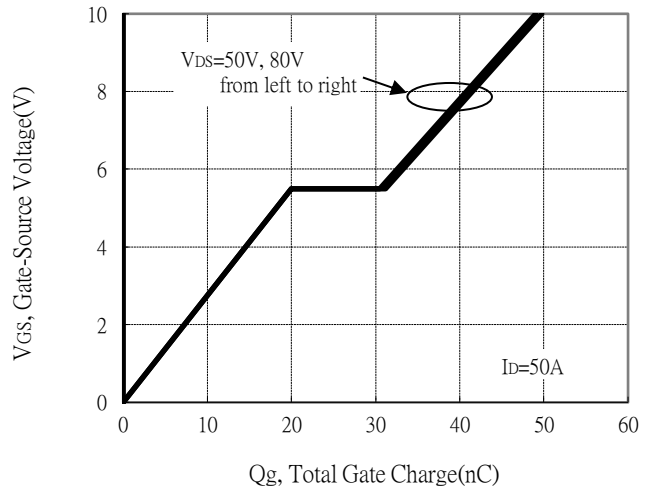
Threshold Voltage vs Junction Temperature



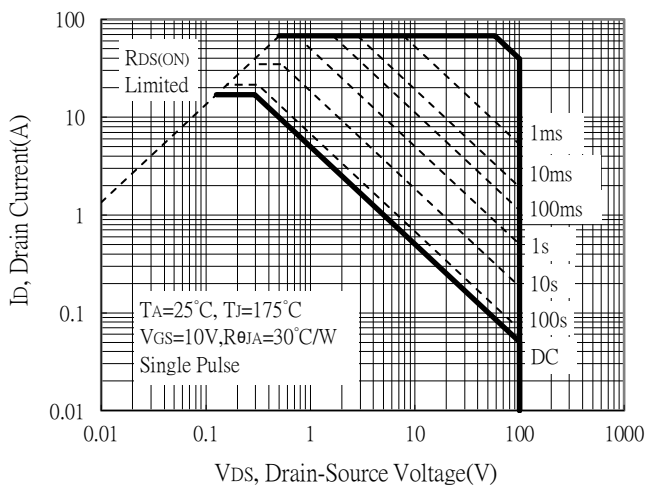
Forward Transfer Admittance vs Drain Current



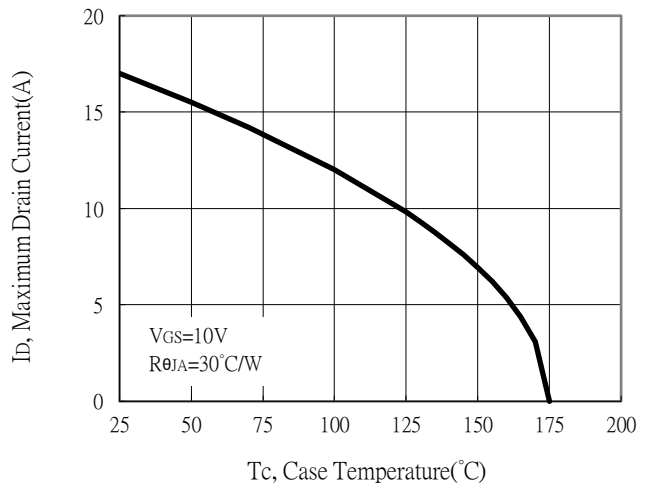
Gate Charge Characteristics



Maximum Safe Operating Area

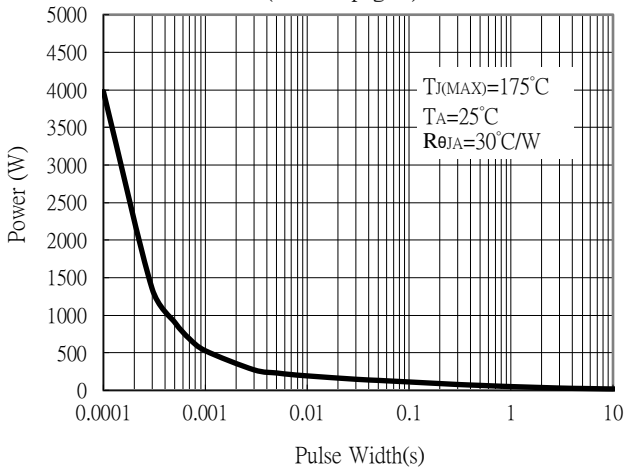


Maximum Drain Current vs Case Temperature

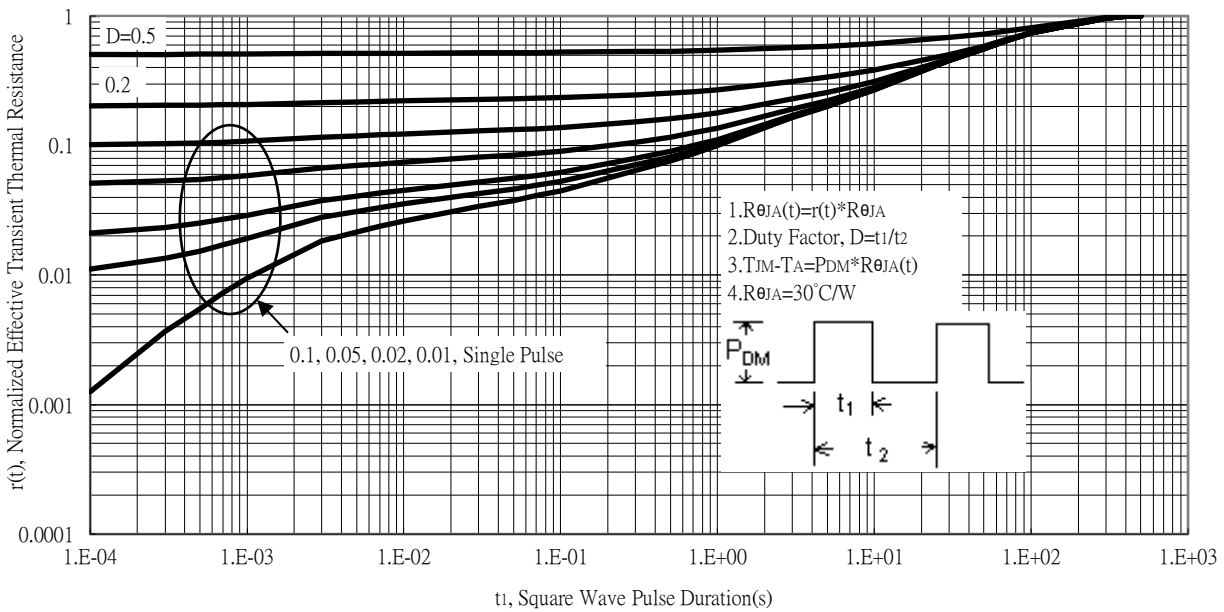


**Typical Characteristics(Cont.)**

Single Pulse Power Rating, Junction to Case  
 (Note on page 2)



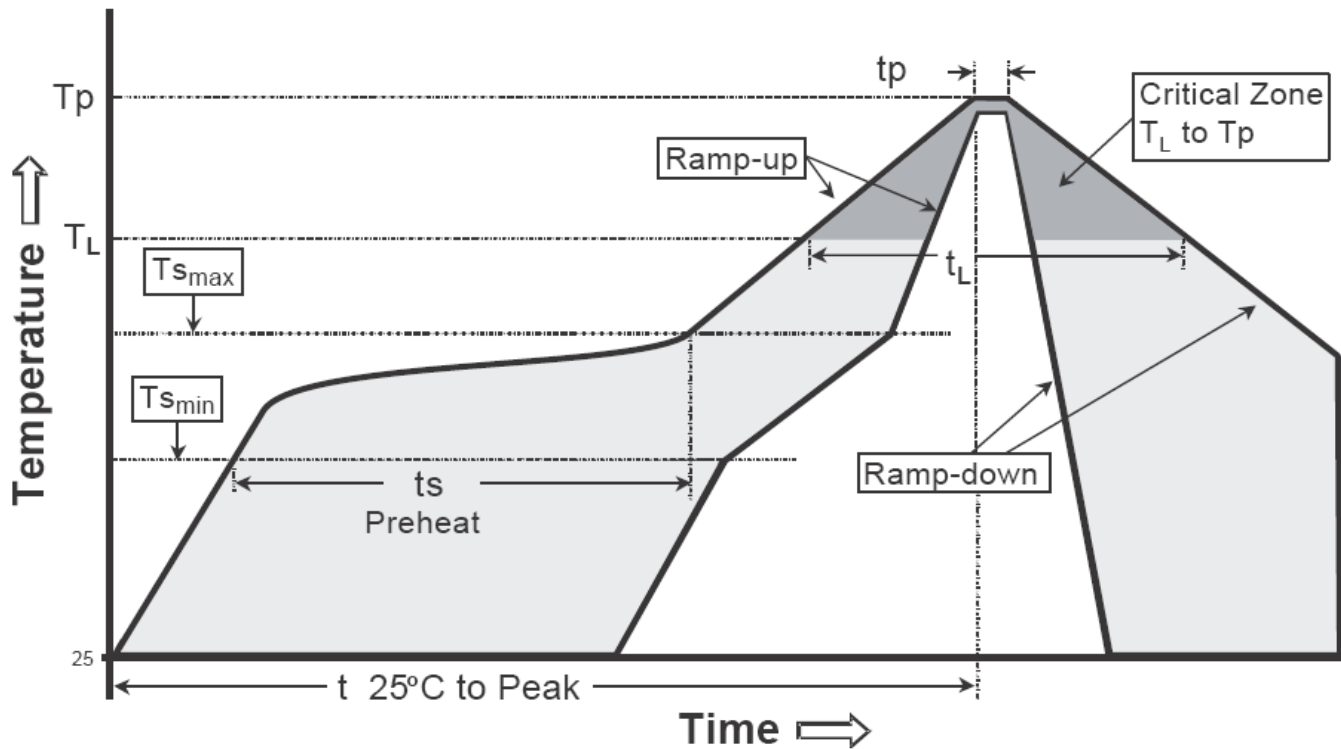
Transient Thermal Response Curves



**Recommended wave soldering condition**

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

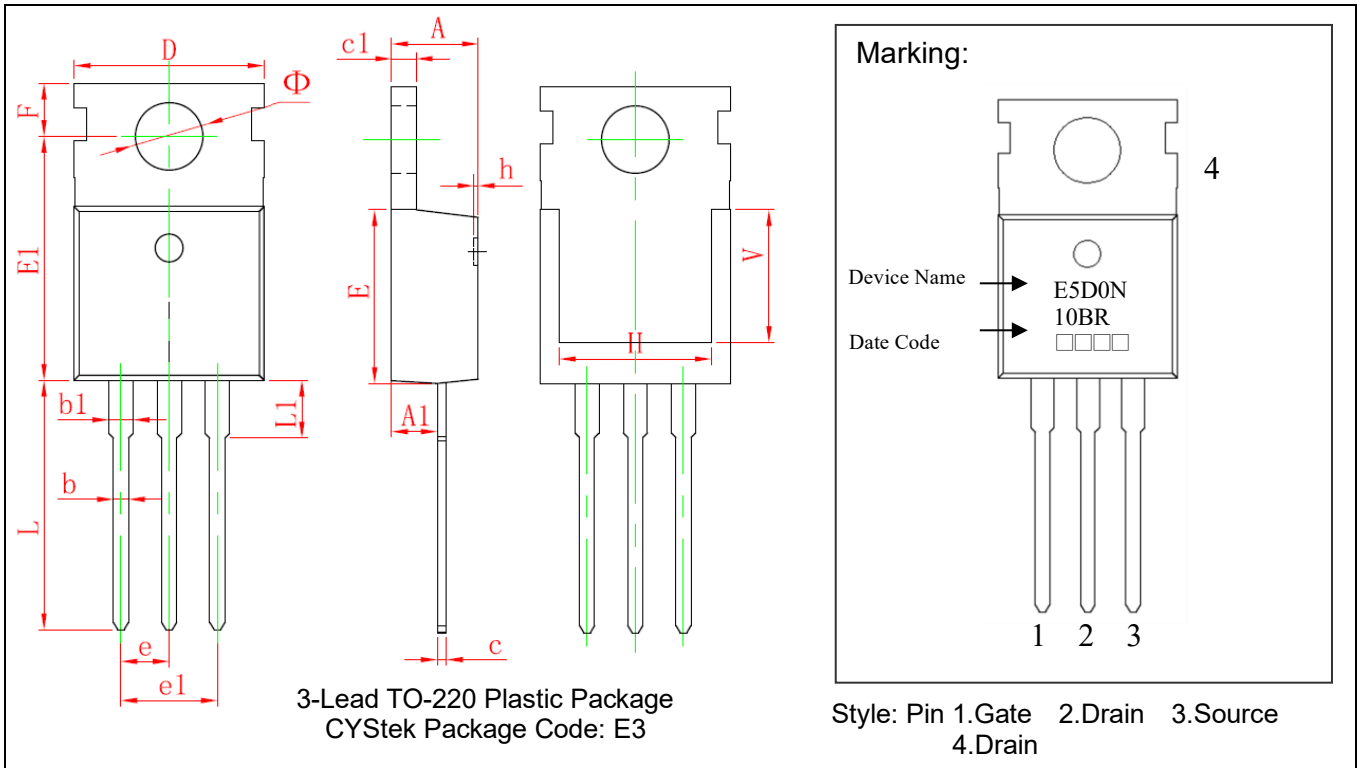
**Recommended temperature profile for IR reflow**



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T <sub>smax</sub> to T <sub>p</sub> )	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T <sub>s min</sub> )	100°C	150°C
-Temperature Max(T <sub>s max</sub> )	150°C	200°C
-Time(t <sub>s min</sub> to t <sub>s max</sub> )	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T <sub>L</sub> )	183°C	217°C
- Time (t <sub>L</sub> )	60-150 seconds	60-150 seconds
Peak Temperature(T <sub>P</sub> )	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

**TO-220 Dimension**



\*: Typical

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	4.400	4.600	0.173	0.181	e	2.540*		0.100*	
A1	2.250	2.550	0.089	0.100	e1	4.980	5.180	0.196	0.204
b	0.710	0.910	0.028	0.036	F	2.650	2.950	0.104	0.116
b1	1.170	1.370	0.046	0.054	H	7.900	8.100	0.311	0.319
c	0.330	0.650	0.013	0.026	h	0.000	0.300	0.000	0.012
c1	1.200	1.400	0.047	0.055	L	12.900	13.400	0.508	0.528
D	9.910	10.250	0.390	0.404	L1	2.850	3.250	0.112	0.128
E	8.950	9.750	0.352	0.384	V	7.500	REF	0.295	REF
E1	12.650	12.950	0.498	0.510	Φ	3.600	3.800	0.142	0.150

**Notes:** 1.Controlling dimension: millimeters.  
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.  
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

**Material:**

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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